



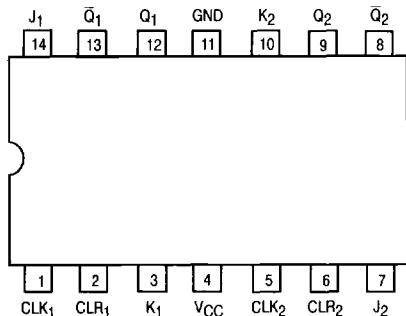
MOTOROLA

Dual J-K Flip-Flop With Clear

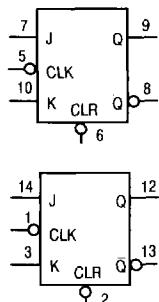
ELECTRICALLY TESTED PER:
MIL-M-38510/30101

The 54LS73A offers individual J, K, clear, and clock inputs. These dual flip-flops are designed so that when the clock goes HIGH, the inputs are enabled and data will be accepted. The logic of the J and K inputs may be allowed to change when the clock pulse is HIGH and the bistable will perform according to the truth table as long as minimum set-up times are observed. Input data is transferred to the outputs on the negative-going edge of the clock pulse.

CONNECTION DIAGRAM

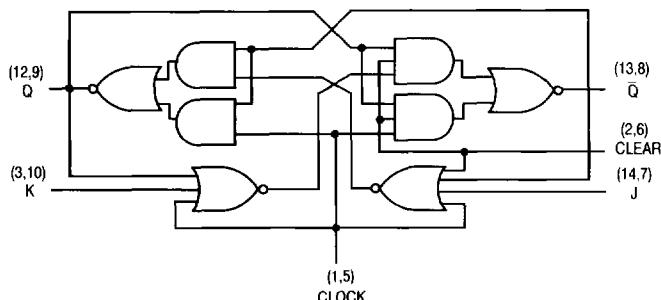


LOGIC SYMBOL



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LOGIC DIAGRAM
(one half shown)



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Military 54LS73A



AVAILABLE AS:

- 1) JAN: JM38510/30101BXA
- 2) SMD: N/A
- 3) 883: 54LS73A/BXAJC

X = CASE OUTLINE AS FOLLOWS:

PACKAGE: CERDIP: C
CERFLAT: D
LCC: SEE 54LS113A

THE LETTER "M" APPEARS
BEFORE THE / ON LCC.

PIN ASSIGNMENTS

FUNCT.	DIL 632-08	FLATS 717-04	BURN-IN (COND. A)
CLK1	1	1	V _{CC}
CLR1	2	2	GND
K ₁	3	3	V _{CC}
V _{CC}	4	4	V _{CC}
CLK2	5	5	V _{CC}
CLR2	6	6	GND
J ₂	7	7	V _{CC}
Q ₂	8	8	V _{CC}
Q ₂	9	9	OPEN
K ₂	10	10	V _{CC}
GND	11	11	GND
Q ₁	12	12	OPEN
Q ₁	13	13	V _{CC}
J ₁	14	14	V _{CC}

BURN-IN CONDITIONS:
V_{CC} = 5.0 V MIN/6.0 V MAX

MODE SELECT — TRUTH TABLE

Operating Mode	Inputs		Outputs		
	C _D	J	K	Q	Q̄
Reset (Clear)	L	X	X	L	H
Toggle	H	h	h	q̄	q
Load "0" (Reset)	H	l	h	L	H
Load "1" (Set)	H	h	l	H	L
Hold	H	l	l	q	q̄

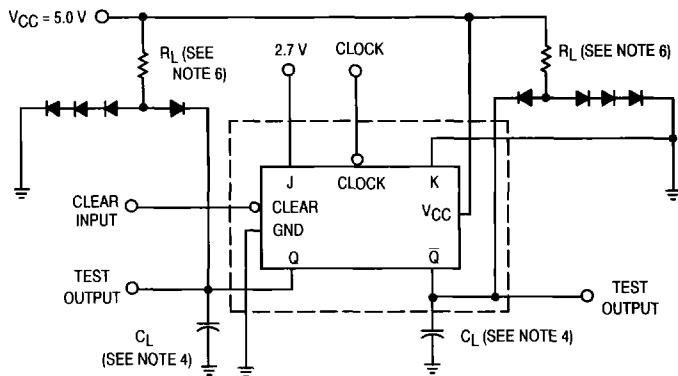
H, h = HIGH Voltage Level

L, l = LOW Voltage Level

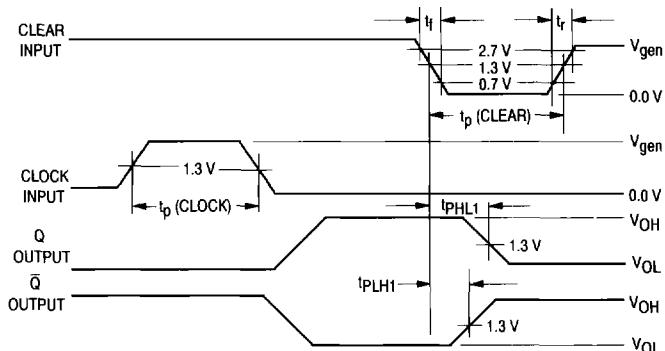
X = Don't Care

l, h, (q) = Lower case letters indicate the state of referenced input (or output) one set-up time prior to the HIGH to LOW clock transition.

CLEAR SWITCHING TEST CIRCUIT



WAVEFORMS

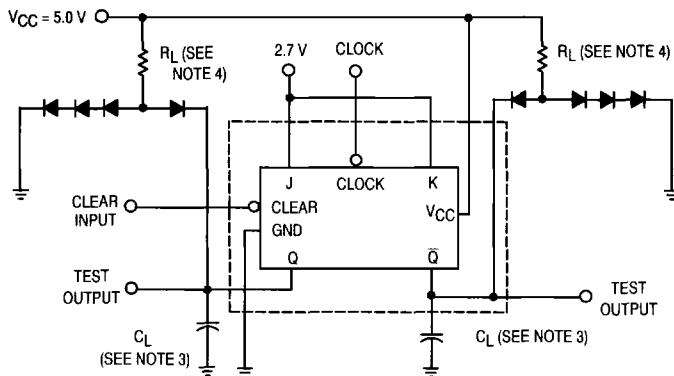


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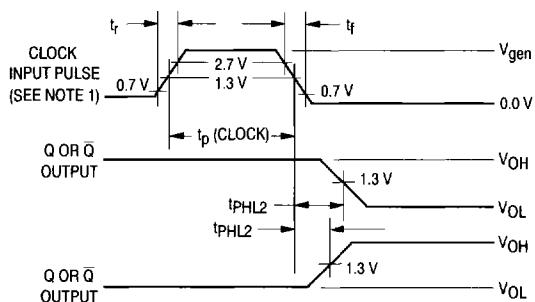
NOTES:

1. Clear inputs dominate regardless of the state of the clock or J-K inputs.
2. Clear input pulse characteristics:
V_{gen} = 3.0 V, t_r ≤ 15 ns, t_f ≤ 6.0 ns,
t_p(clear) = 30 ns, PRR ≤ 1.0 MHz.
3. All diodes are 1N3064, or equivalent.
4. C_L = 50 pF ± 10% (including jig and probe capacitance).
5. Voltage measurements are to be made with respect to network ground terminal.
6. R_L = 2.0 kΩ ± 5.0%.
7. Clock input pulse characteristics:
V_{gen} = 3.0 V, t_p(clock) = 25 ns,
PRR ≤ 1.0 MHz.

SYNCHRONOUS SWITCHING TEST CIRCUIT



WAVEFORMS

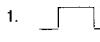


NOTES:

1. Clock input characteristics for t_{PLH} , t_{PHL} (clock to output):
 $V_{gen} = 3.0$ V, $t_r \leq 15$ ns, $t_f = 6.0$ ns, t_p (clock) = 25 ns and
 $PRR \leq 1.0$ MHz. When testing f_{MAX} the clock input characteristics
are: $V_{gen} = 3.0$ V, $t_r = t_f \leq 6.0$ ns, t_p (clock) ≤ 20 ns and $PRR =$
see table.
2. All diodes are 1N3064, or equivalent.
3. $C_L = 50$ pF $\pm 10\%$ (including jig and probe capacitance).
4. $R_L = 2.0$ k Ω $\pm 5.0\%$.

Symbol	Parameter	Limits						Unit	Test Condition (Unless Otherwise Specified)		
	Static Parameters:	+ 25°C		+ 125°C		- 55°C					
		Subgroup 1		Subgroup 2		Subgroup 3					
		Min	Max	Min	Max	Min	Max				
V _{OH}	Logical "1" Output Voltage	2.5		2.5		2.5		V	V _{CC} = 4.5 V, I _{OH} = - 0.4 mA, V _{IN} = 2.0 V, V _{IL} = 0.7 V.		
V _{OL}	Logical "0" Output Voltage		0.4		0.4		0.4	V	V _{CC} = 4.5 V, I _{OL} = 4.0 mA, V _{IH} = 2.0 V, V _{IL} = 0.7 V.		
V _{IC}	Input Clamping Voltage		-1.5					V	V _{CC} = 4.5 V, I _{IN} = - 18 mA, other inputs are open.		
I _{IH1}	Logical "1" Input Current (J & K inputs)		20		20		20	μA	V _{CC} = 5.5 V, V _{IH} = 2.7 V, other input = 4.5 V, CLK & CLR = GND.		
I _{IHH1}	Logical "1" Input Current (J & K inputs)		100		100		100	μA	V _{CC} = 5.5 V, V _{IHH} = 5.5 V, other input = 4.5 V, CLK & CLR = GND.		
I _{IH2}	Logical "1" Input Current (CLR inputs)		60		60		60	μA	V _{CC} = 5.5 V, V _{IH} = 2.7 V, other input = 4.5 V, CLK & J = GND.		
I _{IHH2}	Logical "1" Input Current (CLR inputs)		300		300		300	μA	V _{CC} = 5.5 V, V _{IHH} = 5.5 V, other input = 4.5 V, CLK & J = GND.		
I _{IH3}	Logical "1" Input Current (CLK inputs)		80		80		80	μA	V _{CC} = 5.5 V, V _{IH} = 2.7 V, CLR - K & J = GND.		
I _{IHH3}	Logical "1" Input Current (CLK inputs)		400		400		400	μA	V _{CC} = 5.5 V, V _{IHH} = 5.5 V, CLR - K & J = GND.		
I _{IL1}	Logical "0" Input Current (J & K inputs)	-0.12	-0.36	-0.12	-0.36	-0.12	-0.36	mA	V _{CC} = 5.5 V, V _{IL} = 0.4 V, CLR & K = 4.5 V, CLK = (See Note 2).		
I _{IL2}	Logical "0" Input Current (CLK inputs)	-0.24	-0.72	-0.24	-0.72	-0.24	-0.72	mA	V _{CC} = 5.5 V, V _{IL} = 0.4 V, J & K = 4.5 V, CLR = (See Note 2).		
I _{IL3}	Logical "0" Input Current (CLR inputs)	-0.12	-0.72	-0.12	-0.72	-0.12	-0.72	mA	V _{CC} = 5.5 V, V _{IL} = 0.4 V, CLK - J & K = 4.5 V.		
I _{OS}	Output Short Circuit Current	-15	-100	-15	-100	-15	-100	mA	V _{CC} = 5.5 V, V _{IN} = 4.5 V, CLK - CLR & J = GND, V _{OUT} = 2.25 V.		
I _{CC}	Power Supply Current		8.0		8.0		8.0	mA	V _{CC} = 5.5 V, V _{IN} = 0 V (all inputs), or V _{IN} = 5.5 V (all inputs).		
V _{IH}	Logical "1" Input Voltage	2.0		2.0		2.0		V	V _{CC} = 4.5 V.		
V _{IL}	Logical "0" Input Voltage		0.7		0.7		0.7	V	V _{CC} = 4.5 V.		
	Functional Tests	Subgroup 7		Subgroup 8A		Subgroup 8B			per Truth Table with V _{CC} = 5.0 V, V _{INL} = 0.4 V, and V _{INH} = 2.5 V.		

NOTES:

1.  2.5 V min/5.5 V max
0.0 V
2.  2.5 V min/5.5 V max
0.0 V

54LS73A

Symbol	Parameter	Limits						Unit	Test Condition (Unless Otherwise Specified)		
		+ 25°C		+ 125°C		- 55°C					
	Switching Parameters:	Subgroup 9		Subgroup 10		Subgroup 11					
		Min	Max	Min	Max	Min	Max				
t _{PHL1} t _{PLH1}	Propagation Delay /Data-Output CLR to Q _n	5.0 —	28 20	5.0 —	40 35	5.0 —	40 35	ns	V _{CC} = 5.0 V, C _L = 50 pF, R _L = 2.0 kΩ ± 5.0%. V _{CC} = 5.0 V, C _L = 15 pF, R _L = 2.0 kΩ ± 5.0%.		
t _{PLH1} t _{PLH1}	Propagation Delay /Data-Output CLR to Q _n	5.0 —	21 20	5.0 —	32 27	5.0 —	32 27	ns	V _{CC} = 5.0 V, C _L = 50 pF, R _L = 2.0 kΩ ± 5.0%. V _{CC} = 5.0 V, C _L = 15 pF, R _L = 2.0 kΩ ± 5.0%.		
t _{PHL2} t _{PLH2}	Propagation Delay /Data-Output CLK to Q _n or \bar{Q}_n	5.0 —	30 20	5.0 —	42 37	5.0 —	42 37	ns	V _{CC} = 5.0 V, C _L = 50 pF, R _L = 2.0 kΩ ± 5.0%. V _{CC} = 5.0 V, C _L = 15 pF, R _L = 2.0 kΩ ± 5.0%.		
t _{PLH2} t _{PLH2}	Propagation Delay /Data-Output CLK to Q _n or \bar{Q}_n	5.0 —	22 20	5.0 —	32 27	5.0 —	32 27	ns	V _{CC} = 5.0 V, C _L = 50 pF, R _L = 2.0 kΩ ± 5.0%. V _{CC} = 5.0 V, C _L = 15 pF, R _L = 2.0 kΩ ± 5.0%.		
f _{MAX}	Maximum Clock Frequency	25		25		25		MHz	V _{CC} = 5.0 V, V _{IN} = 2.7 V, C _L = 50 pF, R _L = 2.0 kΩ ± 5.0%.		
f _{MAX}	Maximum Clock Frequency	30						MHz	V _{CC} = 5.0 V, C _L = 15 pF, R _L = 2.0 kΩ ± 5.0%.		

NOTES:

1. f_{MAX}, min. limit specified is the frequency of the input pulse. The output frequency shall be one-half of the input frequency.
2. Tests shall be performed in sequence, attributes data only.
3. The limits specified for C_L = 15 pF are guaranteed but not tested.